SPECIFICATIONS

AO Medium TeO2

Acoustic Velocity 4.2 mm/µs

Active Aperture* 2.5 mm 'L' X 1.5 mm 'H'

Center Frequency (Fc) 200 MHz

RF Bandwidth 50 MHz @ -10 dB Return Loss

Input Impedance 50 Ohms Nominal

VSWR @ Fc 1.3 :1 Max

Wavelength 470-690 nm

Insertion Loss 4 % Max

Reflectivity per Surface 1 % Max

Anti-Reflection Coating MIL-C-48497

Optical Power Density 250 W/mm²

Contrast Ratio 1000 :1 Min

Polarization 90° To Mounting Plane

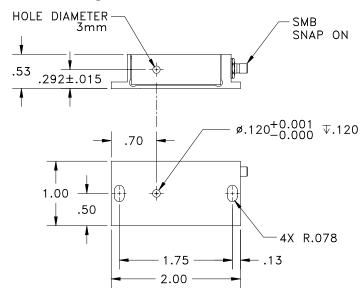
PERFORMANCE VS WAVELENGTH

Wavelength (nm)	470	532	633	690
Saturation RF Power (W)	0.4	0.6	0.9	1.1
Bragg Angle (mr)	11.2	12.7	15.1	16.4
Beam Separation (mr)	22.4	25.4	30.2	32.8

PERFORMANCE VS BEAM DIAMETER

Beam Diameter (µm)	1000	1000	1000	1000
at Wavelength (nm)	470	532	633	690
Diffraction Efficiency (%)	85	85	85	85
Rise Time (nsec)	159	159	159	159

Outline Drawing:



Document

05/03/11

Control

Notes

1. Measurements are in inches unless specified otherwise.

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TOLERANCES: .XX ± .01 .XXX ± .005	DR	Geri Scholz 4/19/2011	Crystal Technology, LLC			
			DESCRIPTION:			
MATERIAL:	CHK		AOMO	3200-	125	
FINISH:	APP		200 MHz Frequency Shifter			
	APP		PART NUMBER: 97-03036-01	REV:	SHEET 1 OF 1	

^{*}Active Aperture: Aperture over which performance specifications apply.